

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/749,489	JWA, SEUNG HEE
	Examiner	Art Unit
	Lee, Calvin	2818 20063/10020

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	260.		

The diagram consists of two horizontal black lines. The upper line is a simple horizontal segment ending with a short vertical tick mark at its right endpoint. The lower line is also a simple horizontal segment, but it features two vertical tick marks: one at its left endpoint and another at its right endpoint.